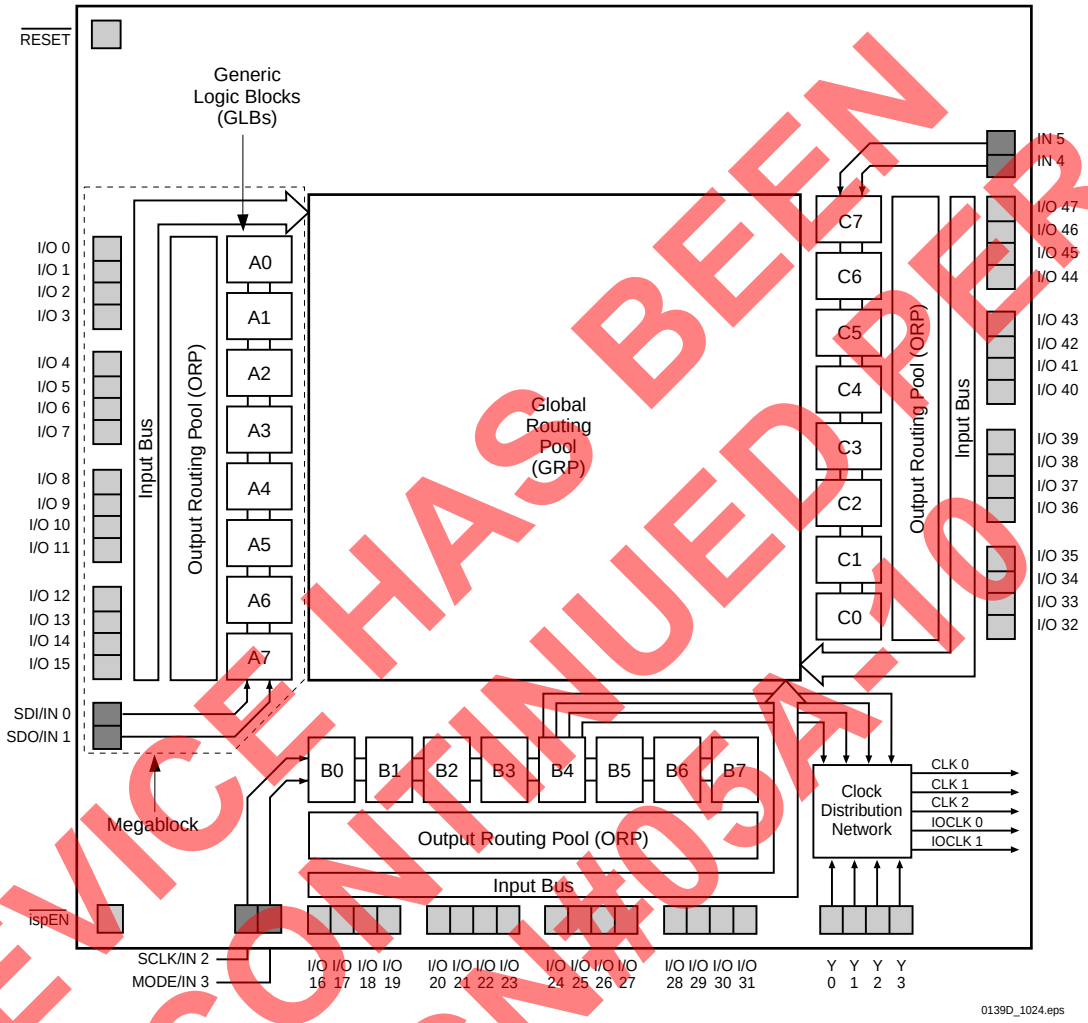
Functional Block Diagram

Figure 1.ispLSI 1024/883 Functional Block Diagram



The device also has 48 I/O cells, each of which is directly connected to an I/O pin. Each I/O cell can be individually programmed to be a combinatorial input, registered input, latched input, output or bi-directional I/O pin with 3-state control. Additionally, all outputs are polarity selectable, active high or active low. The signal levels are TTL compatible voltages and the output drivers can source 4 mA or sink 8 mA.

Eight GLBs, 16 I/O cells, two dedicated inputs and one ORP are connected together to make a Megablock (see figure 1). The outputs of the eight GLBs are connected to a set of 16 universal I/O cells by the ORP. The I/O cells within the Megablock also share a common Output Enable (OE) signal. The ispLSI 1024/883 device contains three of these Megablocks.

The GRP has as its inputs the outputs from all of the GLBs and all of the inputs from the bi-directional I/O cells. All of these signals are made available to the inputs of the GLBs. Delays through the GRP have been equalized to minimize timing skew.

Clocks in the ispLSI 1024/883 device are selected using the Clock Distribution Network. Four dedicated clock pins (Y0, Y1, Y2 and Y3) are brought into the distribution network, and five clock outputs (CLK 0, CLK 1, CLK 2, IOCLK 0 and IOCLK 1) are provided to route clocks to the GLBs and I/O cells. The Clock Distribution Network can also be driven from a special clock GLB (B4 on the ispLSI 1024/883 device). The logic of this GLB allows the user to create an internal clock from a combination of internal signals within the device.

Absolute Maximum Ratings [1]

Supply Voltage V_{CC} ..... -0.5 to +7.0V

Input Voltage Applied ..... -2.5 to V_{CC} +1.0V

Off-State Output Voltage Applied ..... -2.5 to V_{CC} +1.0V

Storage Temperature ..... -65 to 150°C

Case Temp. with Power Applied ..... -55 to 125°C

Max. Junction Temp. (T_J) with Power Applied ... 150°C

1. Stresses above those listed under the "Absolute Maximum Ratings" may cause permanent damage to the device. Functional operation of the device at these or at any other conditions above those indicated in the operational sections of this specification is not implied (while programming, follow the programming specifications).

DC Recommended Operating Conditions

SYMBOL	PARAMETER		MIN.	MAX.	UNITS
V_{CC}	Supply Voltage	Military/883 T_C = -55°C to +125°C	4.5	5.5	
V_{IL}	Input Low Voltage		0	0.8	V
V_{IH}	Input High Voltage		2.0	Vcc + 1	V

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Capacitance (T_A=25°C, f=1.0 MHz)

SYMBOL	PARAMETER	MAXIMUM[1]	UNITS	TEST CONDITIONS
C_1	Dedicated Input Capacitance	10	pf	V_{CC}=5.0V, V_{IN}=2.0V
C_2	I/O and Clock Capacitance	10	pf	V_{CC}=5.0V, $V_{I/O}$, V_Y=2.0V

1. Characterized but not 100% tested.

Table 2- 0006mil

Data Retention Specifications

PARAMETER	MINIMUM	MAXIMUM	UNITS
Data Retention	20	—	Years
Erase/Reprogram Cycles	10000	—	Cycles

Table 2- 0008B

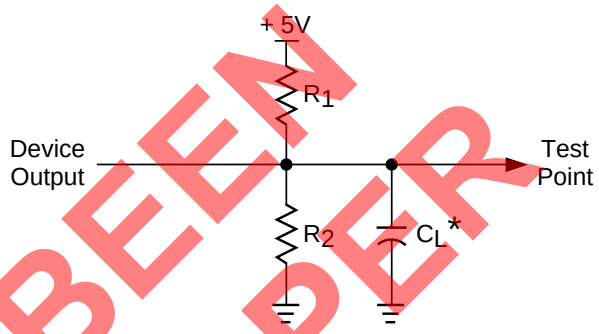
Switching Test Conditions

Input Pulse Levels	GND to 3.0V
Input Rise and Fall Time	≤ 3ns 10% to 90%
Input Timing Reference Levels	1.5V
Output Timing Reference Levels	1.5V
Output Load	See figure 2

3-state levels are measured 0.5V from steady-state active level.

Table 2- 0003

Figure 2. Test Load



*C_L includes Test Fixture and Probe Capacitance.

Output Load Conditions (see figure 2)

Test Condition		R1	R2	CL
A		470Ω	390Ω	35pF
B	Active High	∞	390Ω	35pF
	Active Low	470Ω	390Ω	35pF
C	Active High to Z at V_{OH} - 0.5V	∞	390Ω	5pF
	Active Low to Z at V_{OL} + 0.5V	470Ω	390Ω	5pF

Table 2- 0004A

DC Electrical Characteristics

Over Recommended Operating Conditions

SYMBOL	PARAMETER	CONDITION	MIN.	TYP.[3]	MAX.	UNITS
V_{OL}	Output Low Voltage	I_{OL} =8 mA	–	–	0.4	V
V_{OH}	Output High Voltage	I_{OH} =-4 mA	2.4	–	–	V
I_{IL}	Input or I/O Low Leakage Current	0V ≤ V_{IN} ≤ V_{IL} (MAX.)	–	–	-10	µA
I_{IH}	Input or I/O High Leakage Current	3.5V ≤ V_{IN} ≤ V_{CC}	–	–	10	µA
I_{IL-isp}	isp Input Low Leakage Current	0V ≤ V_{IN} ≤ V_{IL} (MAX.)	–	–	-150	µA
I_{IL-PU}	I/O Active Pull-Up Current	0V ≤ V_{IN} ≤ V_{IL}	–	–	-150	µA
I_{OS}[1]	Output Short Circuit Current	V_{CC} = 5V, V_{OUT} = 0.5V	–	–	-200	mA
I_{CC}[2,4]	Operating Power Supply Current	V_{IL} = 0.5V, V_{IH} = 3.0V f_{TOGGLE} = 1 MHz	–	135	215	mA

1. One output at a time for a maximum duration of one second. V_{out} = 0.5V was selected to avoid test problems by tester ground degradation. Characterized but not 100% tested.
2. Measured using six 16-bit counters.
3. Typical values are at V_{CC} = 5V and T_A = 25°C.
4. Maximum I_{CC} varies widely with specific device configuration and operating frequency. Refer to the Power Consumption section of this datasheet and Thermal Management section of the Lattice Semiconductor Data Book or CD-ROM to estimate maximum I_{CC}.

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External Timing Parameters

Over Recommended Operating Conditions

PARAMETER	TEST COND.[5]	#[2]	DESCRIPTION[1]	-60		UNITS
				MIN.	MAX.	
t_{pd1}	A	1	Data Propagation Delay, 4PT bypass, ORP bypass	–	20	ns
t_{pd2}	A	2	Data Propagation Delay, Worst Case Path	–	25	ns
f_{max} (Int.)	A	3	Clock Frequency with Internal Feedback[3]	60	–	MHz
f_{max} (Ext.)	–	4	Clock Frequency with External Feedback $\left(\frac{1}{t_{su2} + t_{co1}}\right)$	38	–	MHz
f_{max} (Tog.)	–	5	Clock Frequency, Max Toggle[4]	83	–	MHz
t_{su1}	–	6	GLB Reg. Setup Time before Clock, 4PT bypass	9	–	ns
t_{co1}	A	7	GLB Reg. Clock to Output Delay, ORP bypass	–	13	ns
t_{h1}	–	8	GLB Reg. Hold Time after Clock, 4 PT bypass	0	–	ns
t_{su2}	–	9	GLB Reg. Setup Time before Clock	13	–	ns
t_{co2}	–	10	GLB Reg. Clock to Output Delay	–	16	ns
t_{h2}	–	11	GLB Reg. Hold Time after Clock	0	–	ns
t_{r1}	A	12	Ext. Reset Pin to Output Delay	–	22.5	ns
t_{rw1}	–	13	Ext. Reset Pulse Duration	13	–	ns
t_{en}	B	14	Input to Output Enable	–	24	ns
t_{dis}	C	15	Input to Output Disable	–	24	ns
t_{wh}	–	16	Ext. Sync. Clock Pulse Duration, High	6	–	ns
t_{wl}	–	17	Ext. Sync. Clock Pulse Duration, Low	6	–	ns
t_{su5}	–	18	I/O Reg. Setup Time before Ext. Sync. Clock (Y2, Y3)	2.5	–	ns
t_{h5}	–	19	I/O Reg. Hold Time after Ext. Sync. Clock (Y2, Y3)	8.5	–	ns

Table 2-0030-24 mil

1. Unless noted otherwise, all parameters use a GRP load of 4 GLBs, 20 PTXOR path, ORP and Y0 clock.
2. Refer to Timing Model in this data sheet for further details.
3. Standard 16-Bit loadable counter using GRP feedback.
4. f_{max} (Toggle) may be less than $1/(t_{wh} + t_{wl})$. This is to allow for a clock duty cycle of other than 50%.
5. Reference Switching Test Conditions Section.

Internal Timing Parameters[1]

PARAMETER	#[2]	DESCRIPTION	-60		UNITS
			MIN.	MAX.	
Inputs					
tiobp	20	I/O Register Bypass	–	2.7	ns
tiolat	21	I/O Latch Delay	–	4.0	ns
tiosu	22	I/O Register Setup Time before Clock	7.3	–	ns
tioh	23	I/O Register Hold Time after Clock	1.3	–	ns
tioco	24	I/O Register Clock to Out Delay	–	4.0	ns
tior	25	I/O Register Reset to Out Delay	–	3.3	ns
tdin	26	Dedicated Input Delay	–	5.3	ns
GRP					
tgrp1	27	GRP Delay, 1 GLB Load	–	2.0	ns
tgrp4	28	GRP Delay, 4 GLB Loads	–	2.7	ns
tgrp8	29	GRP Delay, 8 GLB Loads	–	4.0	ns
tgrp12	30	GRP Delay, 12 GLB Loads	–	5.0	ns
tgrp16	31	GRP Delay, 16 GLB Loads	–	6.0	ns
tgrp24	32	GRP Delay, 24 GLB Loads	–	8.3	ns
GLB					
t4ptbp	33	4 Product Term Bypass Path Delay	–	8.6	ns
t1ptxor	34	1 Product Term/XOR Path Delay	–	9.3	ns
t20ptxor	35	20 Product Term/XOR Path Delay	–	10.6	ns
txoradj	36	XOR Adjacent Path Delay[3]	–	12.7	ns
tgbp	37	GLB Register Bypass Delay	–	1.3	ns
tgsu	38	GLB Register Setup Time before Clock	1.3	–	ns
tgh	39	GLB Register Hold Time after Clock	6.0	–	ns
tgco	40	GLB Register Clock to Output Delay	–	2.7	ns
tgr	41	GLB Register Reset to Output Delay	–	3.3	ns
tptre	42	GLB Product Term Reset to Register Delay	–	13.3	ns
tptoe	43	GLB Product Term Output Enable to I/O Cell Delay	–	12.0	ns
tptck	44	GLB Product Term Clock Delay	4.6	9.9	ns
ORP					
torp	45	ORP Delay	–	3.3	ns
torpbp	46	ORP Bypass Delay	–	0.7	ns

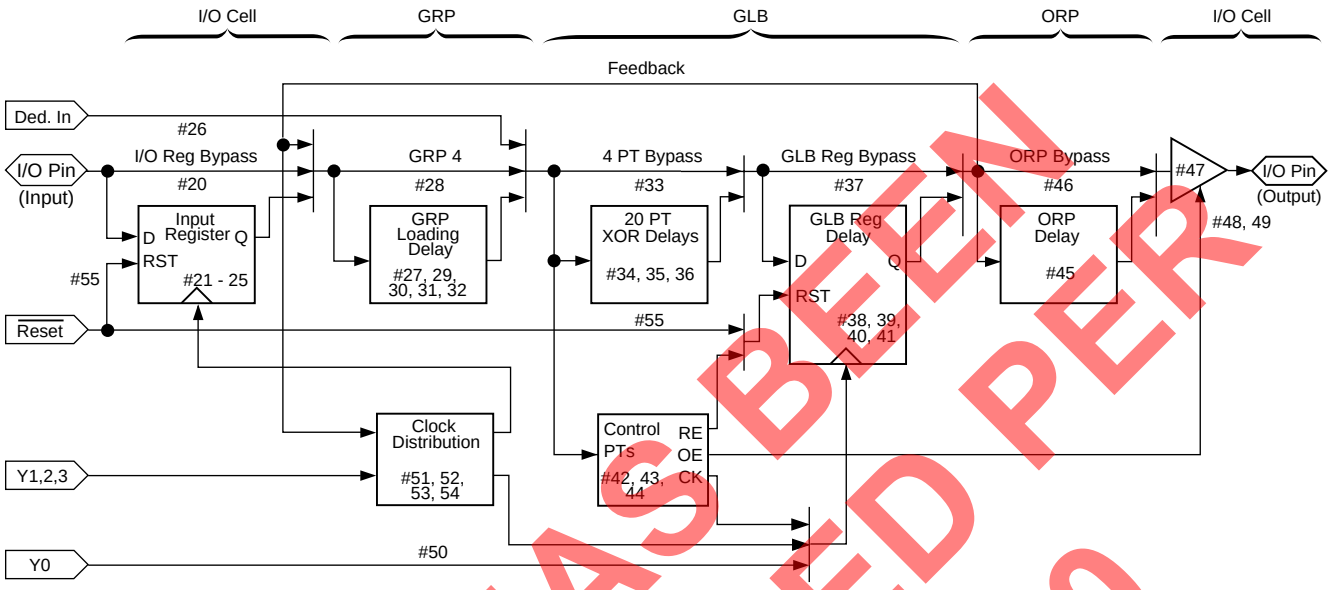
1. Internal Timing Parameters are not tested and are for reference only.
2. Refer to Timing Model in this data sheet for further details.
3. The XOR Adjacent path can only be used by Lattice Hard Macros.

Internal Timing Parameters[1]

PARAMETER	#[2]	DESCRIPTION	-60		UNITS
			MIN.	MAX.	
Outputs					
tob	47	Output Buffer Delay	–	4.0	ns
toen	48	I/O Cell OE to Output Enabled	–	6.7	ns
todis	49	I/O Cell OE to Output Disabled	–	6.7	ns
Clocks					
tgy0	50	Clock Delay, Y0 to Global GLB Clock Line (Ref. clock)	6.0	6.0	ns
tgy1/2	51	Clock Delay, Y1 or Y2 to Global GLB Clock Line	4.6	7.3	ns
tgcp	52	Clock Delay, Clock GLB to Global GLB Clock Line	1.3	6.6	ns
tioy2/3	53	Clock Delay, Y2 or Y3 to I/O Cell Global Clock Line	4.6	7.3	ns
tiocp	54	Clock Delay, Clock GLB to I/O Cell Global Clock Line	1.3	6.6	ns
Global Reset					
tgr	55	Global Reset to GLB and I/O Registers	–	12.0	ns

1. Internal Timing Parameters are not tested and are for reference only.
2. Refer to Timing Model in this data sheet for further details.

ispLSI Timing Model



Derivations of tsu, th and tco from the Product Term Clock[1]

tsu = Logic + Reg su - Clock (min)
= (tiobp + tgrp4 + t20ptxor) + (tgsu) - (tiobp + tgrp4 + tptck(min))
= (#20 + #28 + #35) + (#38) - (#20 + #28 + #44)
7.3 ns = (2.7 + 2.7 + 10.6) + (1.3) - (2.7 + 2.7 + 4.6)

th = Clock (max) + Reg h - Logic
= (tiobp + tgrp4 + tptck(max)) + (tgh) - (tiobp + tgrp4 + t20ptxor)
= (#20 + #28 + #44) + (#39) - (#20 + #28 + #35)
5.3 ns = (2.7 + 2.7 + 9.9) + (6.0) - (2.7 + 2.7 + 10.6)

tco = Clock (max) + Reg co + Output
= (tiobp + tgrp4 + tptck(max)) + (tgco) + (torp + tob)
= (#20 + #28 + #44) + (#40) + (#45 + #47)
25.3 ns = (2.7+ 2.7 +9.9) + (2.7) + (3.3 + 4.0)

Derivations of tsu, th and tco from the Clock GLB[1]

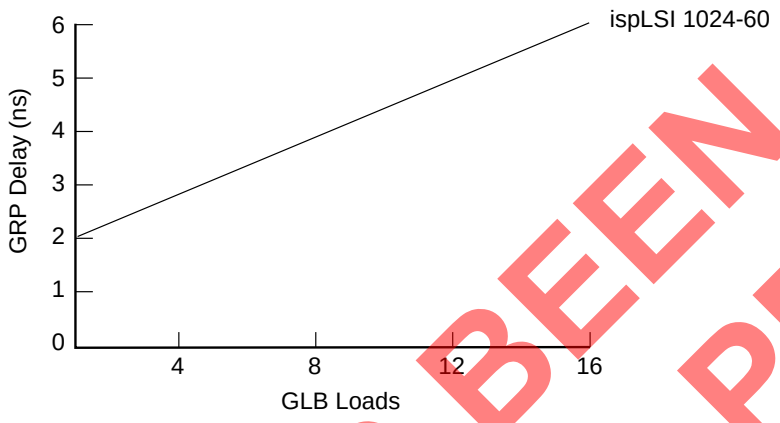
tsu = Logic + Reg su - Clock (min)
= (tiobp + tgrp4 + t20ptxor) + (tgsu) - (tgy0(min) + tgco + tgcp(min))
= (#20 + #28 + #35) + (#38) - (#50 + #40 + #52)
7.3 ns = (2.7 + 2.7 + 10.6) + (1.3) - (6.0 + 2.7 + 1.3)

th = Clock (max) + Reg h - Logic
= (tgy0(max) + tgco + tgcp(max)) + (tgh) - (tiobp + tgrp4 + t20ptxor)
= (#50 + #40 + #52) + (#39) - (#20 + #28 + #35)
5.3 ns = (6.0 + 2.7 + 6.6) + (6.0) - (2.7 + 2.7 + 10.6)

tco = Clock (max) + Reg co + Output
= (tgy0(max) + tgco + tgcp(max)) + (tgco) + (torp + tob)
= (#50 + #40 + #52) + (#40) + (#45 + #47)
25.3 ns = (6.0 + 2.7 + 6.6) + (2.7) + (3.3 + 4.0)

1. Calculations are based upon timing specifications for the ispLSI 1024-60.

Maximum GRP Delay vs GLB Loads



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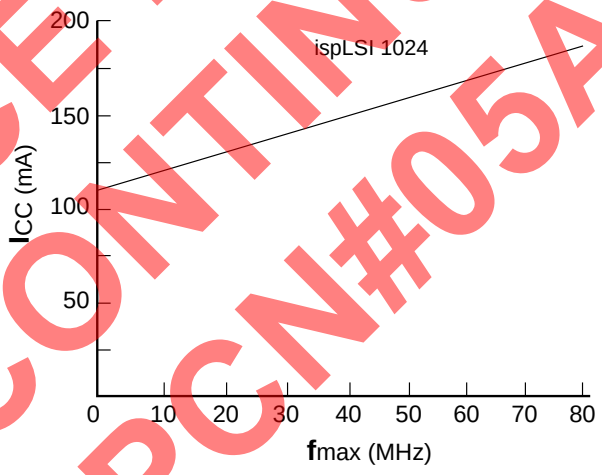
Power Consumption

Power consumption in the ispLSI 1024/883 device depends on two primary factors: the speed at which the device is operating, and the number of Product Terms used. Figure 3 shows the relationship between power and operating speed.

Figure 3. Typical Device Power Consumption vs fmax



Notes: Configuration of Six 16-bit Counters
Typical Current at 5V, 25°C

I_{CC} can be estimated for the ispLSI 1024 using the following equation:

I_{CC} = 42 + (# of PTs * 0.45) + (# of nets * Max. freq * 0.008) where:
# of PTs = Number of Product Terms used in design
# of nets = Number of Signals used in device
Max. freq = Highest Clock Frequency to the device

The I_{CC} estimate is based on typical conditions (V_{CC} = 5.0V, room temperature) and an assumption of 2 GLB loads on average exists. These values are for estimates only. Since the value of I_{CC} is sensitive to operating conditions and the program in the device, the actual I_{CC} should be verified.

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Pin Description

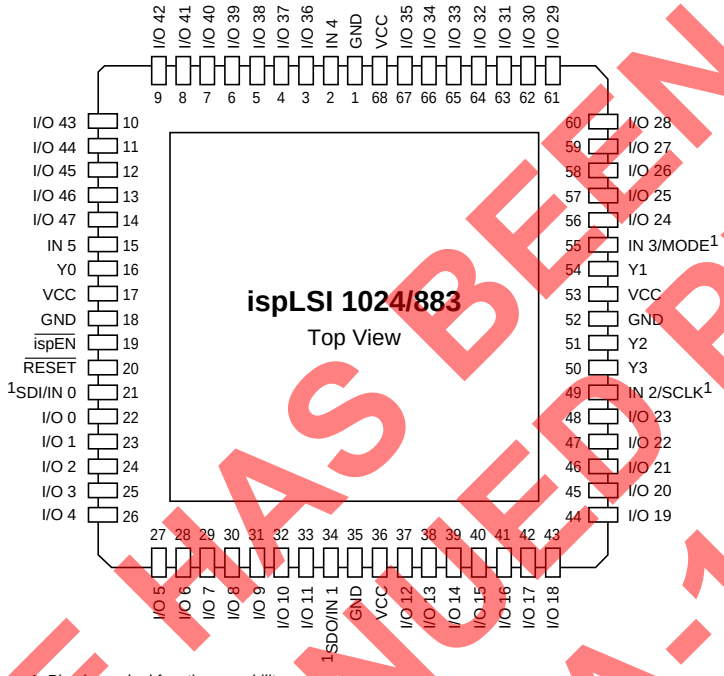
NAME	JLCC PIN NUMBERS	DESCRIPTION
I/O 0 - I/O 3 I/O 4 - I/O 7 I/O 8 - I/O 11 I/O 12 - I/O 15 I/O 16 - I/O 19 I/O 20 - I/O 23 I/O 24 - I/O 27 I/O 28 - I/O 31 I/O 32 - I/O 35 I/O 36 - I/O 39 I/O 40 - I/O 43 I/O 44 - I/O 47	22, 23, 24, 25, 26, 27, 28, 29, 30, 31, 32, 33, 37, 38, 39, 40, 41, 42, 43, 44, 45, 46, 47, 48, 56, 57, 58, 59, 60, 61, 62, 63, 64, 65, 66, 67, 3, 4, 5, 6, 7, 8, 9, 10, 11, 12, 13, 14	Input/Output Pins - These are the general purpose I/O pins used by the logic array.
IN 4 - IN 5	2, 15	Input - These pins are dedicated input pins to the device.
$\overline{\text{ispEN}}$	19	Input - Dedicated in-system programming enable input pin. This pin is brought low to enable the programming mode. The MODE, SDI, SDO and SCLK options become active.
SDI/IN 0[1]	21	Input - This pin performs two functions. When $\overline{\text{ispEN}}$ is logic low, it functions as an input pin to load programming data into the device. SDI/IN 0 is also used as one of the two control pins for the isp state machine. It is a dedicated input pin when $\overline{\text{ispEN}}$ is logic high.
MODE/IN 3[1]	55	Input - This pin performs two functions. When $\overline{\text{ispEN}}$ is logic low, it functions as pin to control the operation of the isp state machine. It is a dedicated input pin when $\overline{\text{ispEN}}$ is logic high.
SDO/IN 1[1]	34	Output/Input - This pin performs two functions. When $\overline{\text{ispEN}}$ is logic low, it functions as an output pin to read serial shift register data. It is a dedicated input pin when $\overline{\text{ispEN}}$ is logic high.
SCLK/IN 2[1]	49	Input - This pin performs two functions. When $\overline{\text{ispEN}}$ is logic low, it functions as a clock pin for the Serial Shift Register. It is a dedicated input pin when $\overline{\text{ispEN}}$ is logic high.
NC[2]	—	No Connect
$\overline{\text{RESET}}$	20	Active Low (0) Reset pin which resets all of the GLB and I/O registers in the device.
Y0	16	Dedicated Clock input. This clock input is connected to one of the clock inputs of all of the GLBs on the device.
Y1	54	Dedicated Clock input. This clock input is brought into the clock distribution network, and can optionally be routed to any GLB on the device.
Y2	51	Dedicated Clock input. This clock input is brought into the clock distribution network, and can optionally be routed to any GLB and/or any I/O cell on the device.
Y3	50	Dedicated Clock input. This clock input is brought into the clock distribution network, and can optionally be routed to any I/O cell on the device.
GND	1, 18, 35, 52	Ground (GND)
VCC	17, 36, 53, 68	V_{CC}

Table 2 - 0002C-24 mil

1. Pins have dual function capability.
2. NC pins are not to be connected to any active signals, Vcc or GND.

Pin Configuration

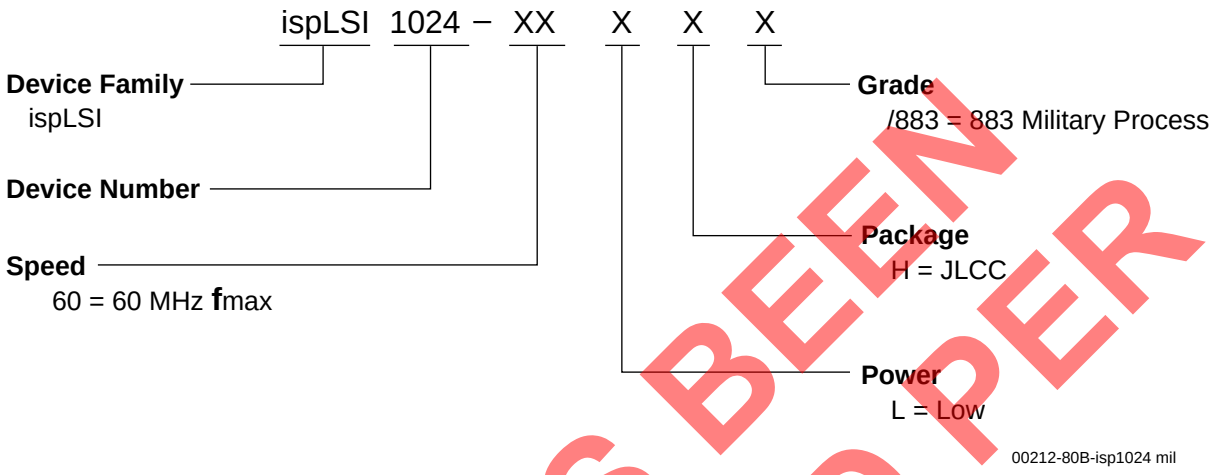
ispLSI 1024/883 68-Pin JLCC Pinout Diagram



1. Pins have dual function capability.

0123-24-isp/JLCC

Part Number Description



00212-80B-isp1024 mil

Ordering Information

MILITARY/883

Family	fmax (MHz)	tpd (ns)	Ordering Number	SMD #	Package
ispLSI	60	20	ispLSI 1024-60LH/883	5962-9476101MXC	68-Pin JLCC

Note: Lattice Semiconductor recognizes the trend in military device procurement towards using SMD compliant devices, as such, ordering by this number is recommended.

Table 2-0041A-24-mil